

ABSTRACT OF THE DISCLOSURE

A contactor is used for testing an integrated circuit electronic component provided with a plurality of electrodes. The contactor includes an insulating
5 base material provided with holes formed at positions corresponding to the electrodes, a first conductive layer having contacts which are plastically deformed portions of the first conductive layer, and
reinforcement members provided on the contacts on a
10 first surface of the contacts. The first surface of the contacts is facing towards the holes. The contacts are provided at positions corresponding to the
electrodes for enabling an electrical connection to the electronic component and are protruded from the
15 insulating base material.